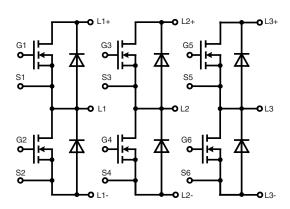


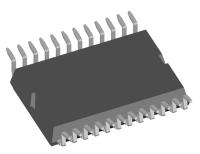
# Three phase full Bridge

with Trench MOSFETs in DCB-isolated high-current package

= 100 V $V_{\rm DSS}$ = 190 A $R_{DSon typ.} = 1.7 \text{ m}\Omega$ 

Part number MTI145WX100GD





Surface Mount Device

## Features / Advantages:

- MOSFETs in trench technology:
  - low R<sub>DSon</sub>
  - optimized intrinsic reverse diode
- Package:
  - high level of integration
  - high current capability
  - aux. terminals for MOSFET control
  - terminals for soldering or welding connections
  - isolated DCB ceramic base plate with optimized heat transfer
- · Space and weight savings

## **Applications:**

#### AC drives

- · in automobiles
  - electric power steering
- starter generator
- · in industrial vehicles
  - propulsion drives
  - fork lift drives
- in battery supplied equipment

## Package: ISOPLUS-DIL®

- · High level of integration
- · RoHS compliant
- · High current capability
- · Aux. Terminals for MOSFET control
- · Terminals for soldering or welding connections
- · Space and weight savings

#### Terms & Conditions of usage

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of The data contained in this product data sheet is exclusively intended not rechinically families stail. The description of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application and assembly notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact your local sales

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact your local sales office Should you intend to use the product in aviation, in health or life endangering or life support applications, please notify. For any such application we urgently recommend

- to perform joint risk and quality assessments;
   the conclusion of quality agreements;
- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures

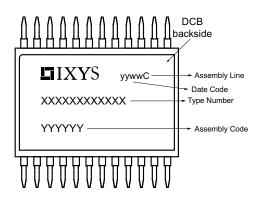
IXYS reserves the right to change limits, test conditions and dimensions.



MOSFET	s				Ratir	ngs	
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
V <sub>DSS</sub>	drain source breakdown voltage	$T_{VJ} = 2$	25°C to 150°C			100	V
V <sub>GS</sub>	gate source voltage max. transient gate source voltage					±15 ±20	V V
I <sub>D25</sub> I <sub>D90</sub>	continuous drain current		$T_{C} = 25^{\circ}C$ $T_{C} = 90^{\circ}C$			190 145	A A
R <sub>DS(on)</sub> 1)	static drain source on resistance	on chip level at $I_D = 100 \text{ A}$ ; $V_{GS} = 10 \text{ V}$	$T_{VJ} = 25^{\circ}C$ $T_{VJ} = 125^{\circ}C$		1.7 2.9	2.2	mΩ
$V_{\rm GS(th)}$	gate threshold voltage	$I_D = 275 \ \mu A; V_{DS} = V_{GS}$	$T_{VJ} = 25^{\circ}C$	2.0	2.7	3.5	V
I <sub>DSS</sub>	drain source leakage current	$V_{DS} = V_{DSS}$ ; $V_{GS} = 0 \text{ V}$	$T_{VJ} = 25^{\circ}C$ $T_{VJ} = 125^{\circ}C$		10	1 100	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	gate source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$				500	nA
R <sub>G</sub>	gate resistance	on chip level			1.9	i	Ω
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	input capacitance output capacitance reverse transfer capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ Mhz}$			11.1 1.94 70		nF nF pF
$egin{array}{c} oldsymbol{Q}_{g} \ oldsymbol{Q}_{gs} \ oldsymbol{Q}_{gd} \end{array}$	total gate charge gate source charge gate drain (Miller) charge	$V_{GS} = 10 \text{ V}; V_{DS} = 50 \text{ V}; I_D = 100 \text{ A}$	1		155 48 27		nC nC nC
$\begin{aligned} & \boldsymbol{t}_{d(on)} \\ & \boldsymbol{t}_{r} \\ & \boldsymbol{t}_{d(off)} \\ & \boldsymbol{t}_{f} \end{aligned}$	turn-on delay time current rise time turn-off delay time current fall time	inductive load $V_{GS} = 10 \text{ V; } V_{DS} = 50 \text{ V}$	T <sub>VJ</sub> = 125°C		135 75 600 40		ns ns ns ns
$E_{on}$ $E_{off}$ $E_{rec(off)}$	turn-on energy per pulse turn-off energy per pulse turn-off reverse recovery losses	$I_D = 100 \text{ A}; R_G = 27 \Omega$			200 600 36		μJ μJ μJ
$\mathbf{R}_{thJC}$	thermal resistance junction to case					0.85	K/W
R <sub>thJH</sub>	thermal resistance junction to heatsink	with heat transfer paste (IXYS te $^{1)}V_{DS} = I_{D} \cdot (R_{DS(on)} + 2 \cdot R_{Pin to Chip})$	st setup)		1.1	1.4	K/W
Source-E	Drain Diode					1	1 1 1 1
<sub>F25</sub>   <sub>F90</sub>	forward current		$T_{C} = 25^{\circ}C$ $T_{C} = 90^{\circ}C$			180 105	A A
$\mathbf{V}_{\mathtt{SD}}$	source drain voltage	$I_F = 100 \text{ A}; V_{GS} = 0 \text{ V}$	$T_{VJ} = 25^{\circ}C$		0.9	1.2	V
Q <sub>RM</sub> I <sub>RM</sub> t <sub>rr</sub>	reverse recovery charge max. reverse recovery current reverse recovery time	$\begin{cases} V_{R} = 50 \text{ V; } I_{F} = 100 \text{ A} \\ R_{G} = 27 \Omega \text{ (di/dt} = 1700 \text{ A/µs)} \end{cases}$	T <sub>vJ</sub> = 125°C		2 54 60		μC A ns



Package	Package ISOPLUS-DIL®				Ratings			
Symbol	Definitions	Conditions		min.	typ.	max.	Unit	
I <sub>RMS</sub>	RMS current	per pin in main current paths (L1+L3+, L1L3-, L1L3) may be additionally limited by external connections (PCB tracks) 2 pins for output L1, L2, L3				75	А	
T <sub>stg</sub>	storage temperature			-55		125	°C	
$T_{op}$	operation temperature			-55		150	°C	
$T_{VJ}$	virtual junction temperature			-55		175	°C	
Weight					13		g	
F <sub>c</sub>	mounting force with clip			50		250	N	
V <sub>ISOL</sub>	isolation voltage	t = 1 second	50/60 Hz, RMS, I <sub>ISOL</sub> ≤ 1 mA	1200			V	
		t = 1 minute		1000			V	
R <sub>pin-chip</sub>	resistance terminal to chip	$V_{DS} = I_{D} \cdot (R_{DS(on)} + 2 \cdot R_{pin to chip})$			0.5		mΩ	
C <sub>P</sub>	coupling capacity	between shorted pins and back side metallization			160		pF	



### Part number

M = MOSFET

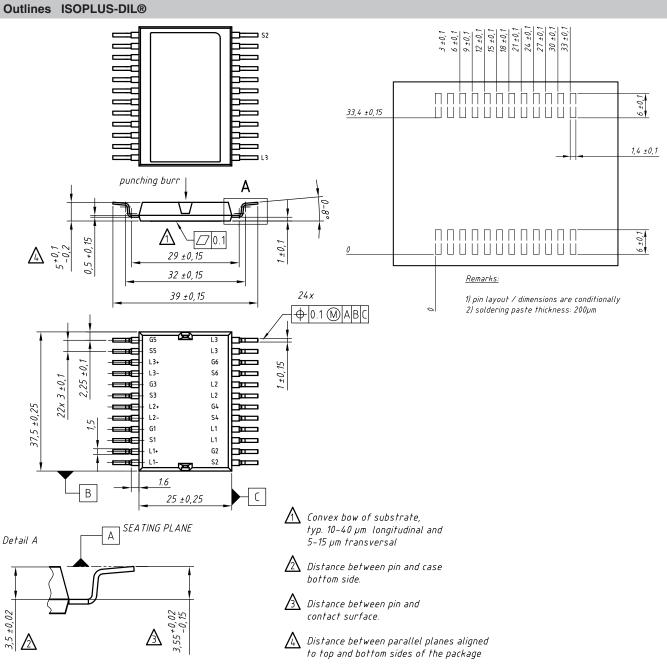
T = Trench

I = Infineon Trench

145 = Current Pating [A]
WX = 6-Pack with separated Phase Legs
100 = Reverse Voltage [V]
GD = ISOPLUS-DIL

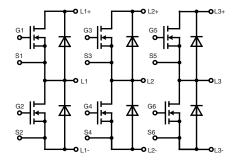
Ordering	Part Name	Marking on Product	<b>Delivering Mode</b>	Base Qty	Ordering Code
Standard	MTI145WX100GD-SMD	MTI145WX100GD	Tube	13	518023





contact pin:

- galv. tin plating, per pin side: Sn 10...25 μm, undercoating Ni 0,2...1 μm
- stamping edges may be free of tin
- puching burr: ≤ 0,05mm



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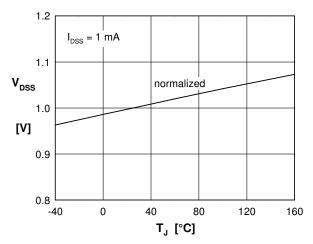


Fig.1 Drain source breakdown voltage  $V_{\rm DSS}$  vs. junction temperature  $T_{\rm VJ}$ 

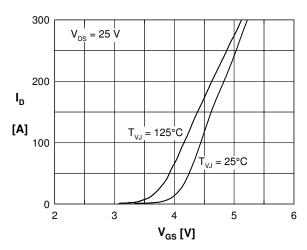


Fig. 2 Typ. transfer characteristics

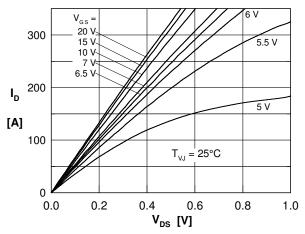


Fig. 3 Typ. output characteristics on die level

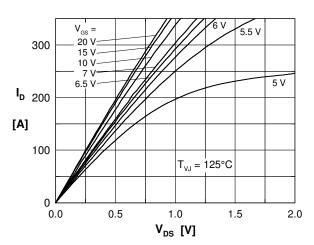


Fig. 4 Typ. output characteristics on die level

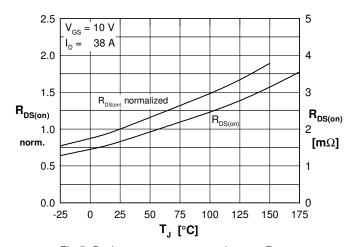
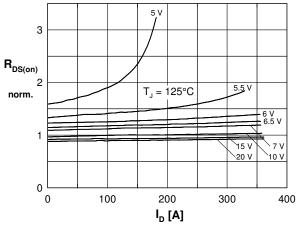


Fig.5 Drain source on-state resistance  $\rm R_{\rm DS(on)}$  vs. junction temperature  $\rm T_{\rm VJ},$  on die level



 $\begin{array}{ccc} \mbox{Fig. 6} & \mbox{Drain source on-state resistance} \\ & \mbox{R}_{\mbox{DS(on)}} \mbox{ versus I}_{\mbox{D}}, \mbox{ on die level} \end{array}$ 

IXYS reserves the right to change limits, test conditions and dimensions.

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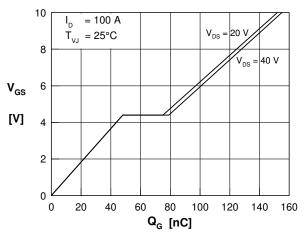


Fig.7 Typical turn on gate charge

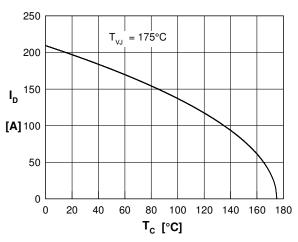


Fig. 8 Drain current I<sub>D</sub> vs. case temperature T<sub>C</sub> (Chip capability)

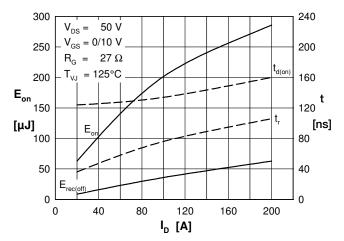


Fig. 9 Typ. turn-on energy and switching times versus drain current, inductive switching

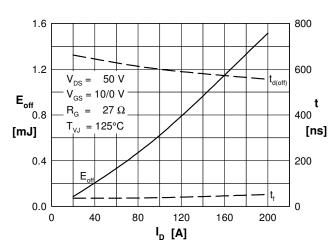


Fig. 10 Typ. turn-off energy and switching times versus drain-current, inductive switching

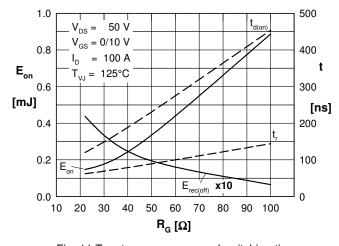


Fig. 11 Typ. turn-on energy and switching times versus gate resistor, inductive switching

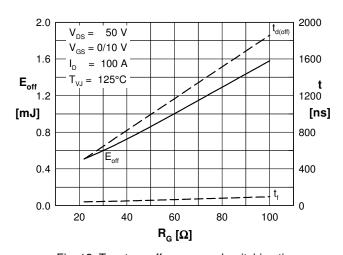


Fig. 12 Typ. turn-off energy and switching times versus gate resistor, inductive switching

IXYS reserves the right to change limits, test conditions and dimensions.



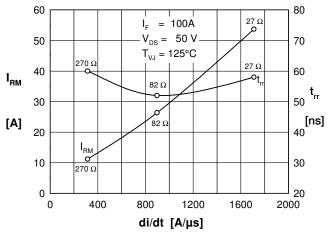


Fig. 13 Typ. reverse recovery characteristics

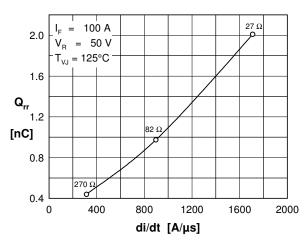


Fig. 14 Typ. reverse recovery characteristics

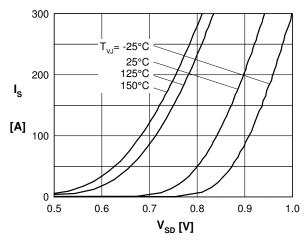


Fig.15 Source current  $I_S$  vs. source drain voltage  $V_{SD}$  (body diode) on die level

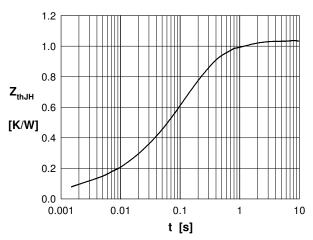


Fig. 16 Typ. thermal impedance junction to heatsink Z<sub>thJH</sub> with heat transfer paste (IXYS test setup)

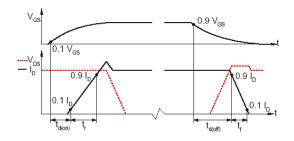


Fig. 17 Definition of switching times